

<b>Notice of References Cited</b>	Application/Control No. 10/799,694	Applicant(s)/Patent Under Reexamination MURAKATA ET AL.	
	Examiner Binh V. Ho	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,351,076	02-2002	Yoshida et al.	315/169.1
*	B	US-6,707,438	03-2004	Ishizuka et al.	345/78
*	C	US-6,617,801	09-2003	Ishizuka et al.	315/169.3
*	D	US-2002/0190934	12-2002	Yoshida et al.	345/76
*	E	US-2004/0189558	09-2004	Yoshida et al.	345/082
*	F	US-6,894,685	05-2005	Ogusu et al.	345/214
*	G	US-6,337,542	01-2002	Hanaki et al.	315/169.3
*	H	US-6,175,193	01-2001	Kishita et al.	315/169.3
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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